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LIST OF PUBLICATIONS CITED BY APPLICANT	<u>Atty. Docket No.</u> 0553-0200.01	<u>Serial No.</u> 10/664,615 Not Assigned
	<u>Applicant</u> Shunpei YAMAZAKI et al	
	<u>Filing Date</u> Herewith 09/19/2003	<u>Group</u> 2823

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*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
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LIST OF PUBLICATIONS CITED BY APPLICANT	<u>Attorney Docket No.</u> 0553-0200.01		<u>Serial No.</u> 10/664,615 Not Assigned			
	<u>Applicant</u> Yamazaki et al					
	<u>Filing Date</u> Herewith 09/19/03	<u>Group</u> 2823				
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KN	10) JP 10-233511 English abstract.
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KN	12) JP 11-191628 English abstract.
KN	13) JP 11-345767 English abstract.
KN	14) JP 11-354442 English abstract.
KN	15) US Patent Application No. 09/433,705 (pending) including specification, claims, abstract and drawings.
KN	16) US Patent Application No. 09/618,930 (pending) to Yamazaki et al., including specification, claims, abstract, drawings and PTO filing receipt.
KN	17) US Patent Application No. 09/714,891 (pending) including specification, claims, abstract and drawings.

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<i>K. Cheung</i>	06/02/04

\*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP form. Draw line through citation if not in conformance and not considered. Include a copy of this form with the next communication to applicant.